Applicant(s)/Patent Under Reexamination Application/Control No. 10/005,641 MALIK ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Kristin Derwich 2132 **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0073233	06-2002	Gross et al.	709/245
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